



Designation: E3061 – 17

Standard Test Method for Analysis of Aluminum and Aluminum Alloys by Inductively Coupled Plasma Atomic Emission Spectrometry (Performance Based Method)¹

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1. Scope

1.1 This test method describes the inductively coupled plasma atomic emission spectrometric analysis of aluminum and aluminum alloys for the following elements:

| Elements | Application Range, % | |
|----------|----------------------|---------|
| | Minimum | Maximum |
| Si | 0.02 | 16.8 |
| Fe | 0.02 | 3.06 |
| Cu | 0.005 | 7.0 |
| Mn | 0.003 | 1.41 |
| Mg | 0.006 | 8.2 |
| Cr | 0.004 | 0.52 |
| Ni | 0.004 | 2.71 |
| Zn | 0.02 | 9.65 |
| Ti | 0.009 | 0.20 |
| Ag | 0.003 | 0.4 |
| As | 0.005 | 0.012 |
| B | 0.009 | 0.027 |
| Ba | 0.002 | 0.03 |
| Be | 0.002 | 0.11 |
| Bi | 0.01 | 0.59 |
| Ca | 0.003 | 0.048 |
| Cd | 0.002 | 0.055 |
| Co | 0.002 | 0.034 |
| Ga | 0.01 | 0.019 |
| Li | 0.001 | 2.48 |
| Mo | 0.02 | 0.15 |
| Na | 0.008 | 0.026 |
| P | 0.01 | 0.025 |
| Pb | 0.009 | 0.51 |
| Sb | 0.01 | 0.28 |
| Sc | 0.01 | 0.065 |
| Sn | 0.008 | 6.28 |
| Sr | 0.0008 | 0.028 |
| Ti | 0.005 | 0.20 |
| Tl | 0.009 | 0.13 |
| V | 0.01 | 0.12 |
| Zr | 0.004 | 0.25 |

1.2 This test method has only been interlaboratory tested for the elements and ranges specified. It may be possible to extend this test method to other elements or different composition ranges if method validation, which includes evaluation of method sensitivity and precision and bias (as described in

¹ This test method is under the jurisdiction of ASTM Committee E01 on Analytical Chemistry for Metals, Ores, and Related Materials and is the direct responsibility of Subcommittee E01.04 on Aluminum and Magnesium.

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Section 14), is performed. Additionally, the validation study must evaluate the acceptability of sample preparation methodology using reference materials and/or spike recoveries. The user should carefully evaluate the validation data against the laboratory's data quality objectives. Method validation of scope extensions is also a requirement of ISO/IEC 17025.

1.3 The values stated in SI units are to be regarded as standard. No other units of measurement are included in this standard.

1.4 This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use. Safety hazard statements are given in Section 10 and specific warning statements are given in Sections 15, 17, 18, 19, 20 and 21.

2. Referenced Documents

2.1 ASTM Standards:²

- B985 Practice for Sampling Aluminum Ingots, Billets, Castings and Finished or Semi-Finished Wrought Aluminum Products for Compositional Analysis
- D1193 Specification for Reagent Water
- E34 Test Methods for Chemical Analysis of Aluminum and Aluminum-Base Alloys
- E50 Practices for Apparatus, Reagents, and Safety Considerations for Chemical Analysis of Metals, Ores, and Related Materials
- E135 Terminology Relating to Analytical Chemistry for Metals, Ores, and Related Materials
- E177 Practice for Use of the Terms Precision and Bias in ASTM Test Methods
- E406 Practice for Using Controlled Atmospheres in Spectrochemical Analysis
- E691 Practice for Conducting an Interlaboratory Study to Determine the Precision of a Test Method

² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For Annual Book of ASTM Standards volume information, refer to the standard's Document Summary page on the ASTM website.

E716 Practices for Sampling and Sample Preparation of Aluminum and Aluminum Alloys for Determination of Chemical Composition by Spark Atomic Emission Spectrometry

E1329 Practice for Verification and Use of Control Charts in Spectrochemical Analysis

E1452 Practice for Preparation of Calibration Solutions for Spectrophotometric and for Spectroscopic Atomic Analysis (Withdrawn 2005)³

E1479 Practice for Describing and Specifying Inductively Coupled Plasma Atomic Emission Spectrometers

E2857 Guide for Validating Analytical Methods

2.2 *ISO Standards*⁴

ISO/IEC 17025 General Requirements for the Competence of Calibration and Testing Laboratories

ISO Guide 98-3 Uncertainty of Measurement Part 3: Guide to the Expression of Uncertainty in Measurement (GUM:1995) - First Edition

3. Terminology

3.1 *Definitions*—For definitions of terms used in this test method, refer to Terminology **E135**.

4. Summary of Test Method

4.1 The test specimen, in the form of drillings, chips, millings, turnings, small pieces or powder, is dissolved in a caustic solution or a mixture of dilute mineral acids and hydrogen peroxide or sodium nitrite and the resulting solutions are measured using inductively coupled plasma atomic emission spectrometry. The spectrometer is calibrated using calibration solutions prepared to match the sample matrix, using a pure aluminum stock solution prepared in **15.2** and stock solutions traceable to an SI unit through a national metrology laboratory or stock solutions prepared as directed in Practice **E1452**.

5. Significance and Use

5.1 This test method for the analysis of aluminum and aluminum alloys is primarily intended to test material for compliance with The Aluminum Association Inc.⁵ registered composition limits or other specified composition limits for aluminum and aluminum alloys.

5.2 It is assumed that all who use this test method will be trained analysts capable of performing common laboratory procedures skillfully and safely, and that the work will be performed in a properly equipped laboratory.

5.3 This is a performance-based test method that relies more on the demonstrated quality of the test result than on strict adherence to specific procedural steps. It is expected that laboratories using this test method will prepare their own work instructions. These work instructions should include detailed

operating instructions for the specific laboratory, the specific reference materials employed, and performance acceptance criteria.

6. Interferences

6.1 The effect of potential spectral overlap interferences and background will vary based on the wavelengths selected, instrument design, and may vary from instrument to instrument of the same design. Variation of excitation conditions or operating parameters may enhance or minimize these interferences. For these reasons, the effect of the potential interferences must be thoroughly investigated for each element and matrix on the instrument chosen for analysis. Practice **E1479** describes the typical physical and spectral interferences encountered during the inductively coupled plasma spectrometric analysis of metal alloys. Potential spectral interferences for recommended wavelengths are given in **Table 1**. The user is responsible for ensuring the absence of, or for compensating for, interferences that may bias test results obtained using their particular spectrometer.

6.2 The use of an internal standard may compensate for the physical interferences resulting from differences between sample and calibration solutions transport efficiencies.

6.3 Shifts in background intensity levels because of, for example, recombination effects or molecular band contributions, or both, may be corrected by the use of an appropriate background correction technique. Direct spectral overlaps are best addressed by selecting alternative wavelengths. If alternate wavelengths are not available, spectral interference studies should be conducted on all new matrices to determine the interference correction factor(s) that must be applied to compositions obtained from certain spectral line intensities to minimize biases. Some instrument manufacturers offer software options that mathematically correct for direct spectral overlaps, but the user should carefully evaluate this approach to spectral correction.

6.4 Modern ICP spectrometers typically have software that allows comparison of a sample spectrum to the spectrum obtained from a blank solution. The user of this test method must examine this information to ascertain the need for background correction and the correct placement of background points.

6.5 **Table 1** recommends wavelengths from the NIST Atomic Spectra Database⁶ that may be used for the analysis of aluminum and aluminum alloys. In this database, wavelengths of less than 200 nm were measured in vacuum and wavelengths greater than or equal to 200 nm were measured in air. Software tables for individual instruments may list wavelengths somewhat differently, as instrument optical path atmospheric conditions may vary.

6.6 Information on potential spectral interfering elements typically found in aluminum alloys was provided by some of the laboratories participating in the interlaboratory study and

³ The last approved version of this historical standard is referenced on www.astm.org.

⁴ Available from American National Standards Institute (ANSI), 25 W. 43rd St. 4th Floor, New York, NY 10036, <http://www.ansi.org>

⁵ Available from The Aluminum Association Inc., 1400 Crystal Drive, Arlington, VA 22202, <http://www.aluminum.org/>

⁶ Available from The National Institute of Standards and Technology 100 Bureau Dr., Gaithersburg, MD 20899 <https://www.nist.gov/>

TABLE 1 Analytical Lines and Possible Interferences

| Element | Wavelength, nm | Possible Interferences |
|------------|----------------|------------------------|
| Antimony | 206.833 | W, Fe, Ni, Be |
| | 259.805 | Fe |
| Arsenic | 189.042 | Cr |
| | 193.759 | Zr |
| | 197.262 | Pb |
| Barium | 455.403 | Zr |
| | 493.409 | |
| Beryllium | 234.861 | Fe, Zr |
| | 313.042 | Ti, V |
| | 313.107 | Ti |
| Bismuth | 222.825 | Cr, Cu, Ti |
| | 223.061 | Cu, Ni, Ti |
| | 306.772 | |
| Boron | 208.959 | Sn, Fe |
| | 249.678 | Sn, Fe, Ni, Ca |
| | 249.773 | Ni, V |
| Cadmium | 226.502 | Co, Ni |
| | 228.802 | As |
| Calcium | 315.887 | Cr, Zr |
| | 317.933 | W |
| | 393.366 | Zr |
| Chromium | 205.552 | Be, Cu, Ni |
| | 267.716 | |
| | 283.563 | |
| | 357.869 | Zr |
| Cobalt | 228.616 | Mo, Ni, Fe |
| | 238.892 | Fe, Mo |
| Copper | 221.458 | Cr |
| | 221.810 | Si |
| | 223.008 | Bi, Mn, Ti, V |
| | 224.700 | Ni |
| | 324.754 | |
| 327.396 | | |
| Gallium | 294.364 | Fe, Ti, Cr |
| | 417.206 | Ni, Fe, Co |
| Indium | 410.172 | Cr, Ti |
| | 451.131 | Mo |
| Iron | 238.204 | V, Zr |
| | 239.562 | |
| | 259.837 | |
| | 259.940 | |
| Lead | 182.203 | |
| | 220.353 | Bi |
| | 283.306 | Cr |
| Lithium | 670.784 | Co, Mo, Fe |
| Magnesium | 257.610 | Mn, Ti |
| | 259.373 | Mn |
| | 260.569 | Mn, Ti, V |
| | 293.306 | Fe, Zr |
| | 293.930 | Zr |
| Manganese | 257.610 | |
| | 259.373 | |
| | 260.569 | Ti |
| | 293.306 | Cr |
| | 293.930 | |
| Molybdenum | 202.030 | Ni, Co, Mn |
| | 277.540 | Al |

TABLE 1 *Continued*

| Element | Wavelength, nm | Possible Interferences |
|------------|----------------|------------------------|
| Nickel | 221.647 | |
| | 231.604 | |
| | 232.003 | |
| | 239.452 | |
| Phosphorus | 177.499 | Cu, Be |
| | 178.287 | Al |
| Potassium | 404.721 | Ba |
| | 766.490 | Mo, Cr |
| Scandium | 361.384 | Mo, Zr, Cr |
| | 363.075 | Ca, Fe |
| Silicon | 212.412 | V |
| | 250.690 | V |
| | 251.612 | V, Zn |
| | 288.158 | Cr, Zr |
| Silver | 328.068 | Mn |
| | 338.289 | Cr, Sb |
| Sodium | 330.237 | |
| | 589.592 | Cr, Zn |
| Strontium | 407.771 | Fe |
| | 421.552 | Cr, Cu |
| Tin | 189.989 | Ti |
| | 242.949 | Fe |
| Thallium | 276.787 | |
| | 190.896 | |
| Titanium | 323.452 | Ni, Zr |
| | 323.657 | Mn, Zr |
| | 334.904 | |
| | 334.941 | |
| | 336.121 | Ni |
| Vanadium | 337.280 | Zr |
| | 290.646 | Ti |
| | 290.882 | Cr |
| | 292.402 | Cr |
| | 310.230 | Ni |
| Zinc | 311.838 | Cr, Ti |
| | 202.548 | Cr, Cu, Mg, Ni |
| | 206.200 | Bi, Cr, Ti |
| | 213.856 | Cu, Ni, Ti, V |
| | 472.216 | Bi |
| Zirconium | 481.053 | |
| | 327.305 | |
| | 339.198 | |
| | 343.823 | |
| | 349.621 | Mn |

may have originated from sources such as recognized wavelength reference tables, instrument manufacturer's software wavelength tables, an individual laboratory's wavelength research studies, or a combination thereof.

6.7 The user must verify that the selected wavelength performs acceptably in their laboratory, preferably during method validation (see Section 23). Total dissolved solids, pH, and viscosity should be similar between sample solutions and

calibration solutions. The user also may choose to use multiple wavelengths to help verify that line selection is optimized for the particular alloy being analyzed. It is recommended that when wavelengths and appropriate spectral corrections are determined, the user of this test method should specify this information or reference instrument programs that include this information in their laboratory analysis procedures.

7. Apparatus

7.1 *Inductively Coupled Plasma Atomic Emission Spectrometers*—Refer to Practice E1479 for attributes to consider when selecting an appropriate instrument.

8. Reagents and Materials

8.1 Reagents:

8.1.1 *Purity and Composition of Reagents*⁷—The purity and composition of chemical reagents shall conform to the requirements prescribed in Practices E50. Reagent grade chemicals or better shall be used in all tests.

8.1.2 *Alcohol*, ethanol or methanol.

8.1.3 *Boric Acid* (H_3BO_3).

8.1.4 *Hydrogen Peroxide* (H_2O_2), 30 %.

8.1.5 *10.5 N Sodium Hydroxide* (NaOH) Solution.

8.1.6 *4 % Sodium Nitrite* ($NaNO_2$) Solution.

8.1.7 Metals of the highest purity available and having known impurity content should be used if preparing stock solutions as directed in Practice E1452.

8.1.8 *Purity of Water*—References to water shall be understood to mean reagent water, Type II grade, as defined by Specification D1193. The water purification method used must be capable of removal of all elements that might bias the test results.

8.1.9 *Argon*, of 99.998 % purity, has been found satisfactory. For information on gas handling, refer to Practice E406.

8.1.10 *Stock Solutions*, if needed, shall be prepared as directed in Practice E1452.

8.1.11 *Certified Reference Materials (CRMs)*, in chip form are available from some national metrology organizations and commercial sources.

8.1.12 *Single Element Certified Reference Material Solutions*—are available from some national metrology organizations and commercial sources.

8.1.13 *Aluminum Metal (Al)*, for matrix matching calibration solutions. Aluminum that is at least 99.999 % is recommended. Aluminum that is less pure may be used provided the impurities are not present at levels that affect the measured amount for elements of interest or the internal standard if used.

⁷ *Reagent Chemicals, American Chemical Society Specifications*, American Chemical Society, Washington, DC. For suggestions on the testing of reagents not listed by the American Chemical Society, see the *United States Pharmacopeia and National Formulary*, U.S. Pharmacopeial Convention, Inc. (USPC), Rockville, MD.

8.2 *Internal Standard*—The use of an internal standard is not required but is recommended. The use of an internal standard may compensate for the physical interferences resulting from differences in sample and calibration solutions transport efficiency. Lanthanum, Co, Sc, Be, and Y were used by participants in the Interlaboratory Study (ILS). Wavelengths used and potential interferences are given in Table 2. It is important that the element chosen for an internal standard is not present in the samples at a level that will affect the analysis.

9. Control Materials

9.1 A laboratory may procure or produce a chip material with a composition that is similar to the samples for use as a control material. These chips should have low heterogeneity and be well blended. Users of this test method may also use certified reference materials as control materials.

9.2 A laboratory may find it difficult to procure or produce the materials for all of the necessary analytes or alloys. Here, it is acceptable to prepare equivalent reference material solutions using the procedure described in Section 15 for use as control solutions.

10. Hazards

10.1 This test method involves the use of concentrated mineral acids. Read and follow label precautions carefully before using. **Warning**—This method involves the use of HF. HF is extremely dangerous. Read and follow label precautions, SDS information, and Practices E50 for HF handling. For precautions to be observed in the use of certain other reagents in this test method, refer to Practices E50.

11. Sampling

11.1 Refer to Practices B985, E34, and E716 for procedures to sample aluminum and aluminum alloys that provide a representative sample.

12. Sampling, Test Specimens, and Test Units

12.1 Test specimens should be obtained by milling or drilling to obtain drillings, chips, millings, or turnings that are clean and of sufficient quantity to generate test specimens of at least 0.1 g for dissolution and analysis. Powdered aluminum can typically be used as-is.

NOTE 1—Antimony, arsenic, bismuth, and phosphorus may be volatilized during the process of obtaining drillings, chips, millings, or turnings

TABLE 2 Wavelengths Used and Potential Interferences

| Internal Standard Element | Wavelength, nm | Potential Interference |
|---------------------------|----------------|------------------------|
| Beryllium | 234.861 | Fe, Zr |
| | 313.042 | Ti, V |
| | 313.107 | Ti |
| | 228.616 | Mo, Ni, Fe |
| Cobalt | 238.892 | Fe, Mo |
| Lanthanum | 379.477 | Fe |
| Scandium | 361.384 | Mo, Zr, Cr |
| Yttrium | 363.075 | Ca, Fe |
| | 371.029 | Ti |

if the metal overheats. Lubricating the metal with methanol or ethanol during machining is recommended. Pin samples or small pieces may also be used to prevent the loss of volatile elements.

13. Preparation of Apparatus

13.1 Analytical instrumentation and sample preparation equipment shall be installed and operated as directed by the manufacturer.

13.2 Using the manufacturer's ICP-AES instrument operation software, conduct start-up procedures and adjustments to the analytical instrument as directed in the manufacturer's operation instructions. Prepare a method or program appropriate to calibrate and measure the elements of interest for the selected wavelengths. Optimize the ICP-AES instrument parameters. Profile the spectrometer as specified in the manufacturers' instructions to ensure optical alignment.

14. Sensitivity and Precision

14.1 Prior to calibration, establish that the instrument being used is capable of demonstrating acceptable sensitivity and precision for the elements being determined. Once it has been demonstrated that the instrument has acceptable sensitivity and precision for these elements, it is not necessary to routinely evaluate sensitivity and precision. Evaluate equipment sensitivity and precision as described in 14.2 and 14.3 .

14.2 *Sensitivity*—Sensitivity shall be evaluated by establishing two-point calibrations for each element being determined using the blank and a high calibration solution prepared as described in Section 15. After thorough rinsing, the blank solution is measured 10 times. Calculate 3 times the standard deviation of these measurements to approximate the limit of detection. Calculate 10 times the standard deviation to approximate the limit of quantification. If the instrument/parameter selection of the user does not produce an estimated limit of detection equal to or better than the lower scope limit of the method for the element(s) being determined, then it is probable the method user will be unable to meet the method's lower scope limit. If the instrument/parameter selection of the user does not produce a limit of quantification equal to or better than the lower scope limit of the method for the element(s) being determined, then it is possible the method user will be unable to consistently meet the method's lower scope limit.

14.3 *Precision*—The short-term precision shall be determined as follows. Using the two-point calibration generated in 14.2, measure the high calibration solution 10 times using the instrument/parameters selected by the method user. Calculate the % Relative Standard Deviation (% RSD) as follows:

$$\% RSD = 100 \frac{s}{\bar{C}} \quad (1)$$

where:

s = estimated standard deviation of the 10 measurements, and

\bar{C} = average of the 10 results for the measured composition.

The calculated % RSD should be approximately 1 %. However, as compositions decrease or as intensities approach detector saturation, % RSD may tend to increase, while not necessarily affecting the quality of the reported result. During the interlaboratory study, % RSD values were typically ap-

proximately 1 %, although some values approached 5 %. The user of this test method must decide if precision is adequate for meeting data quality objectives. Practice E1479 provides limited guidance for the parameters that may have an effect on instrument precision. Instrument troubleshooting manuals provided by the manufacturer of the equipment may also provide guidance for optimizing performance for the specific instrument being used.

15. Calibration

15.1 *Calibration Solutions and Preparation of Calibration Curve*—In this test method, calibration is based on laboratory-prepared matrix-matched calibration solutions. Matrix-matched calibration solutions are solutions that contain the approximate amount of aluminum and acid found in typical sample solutions. They are intended to model the physical behavior of sample solutions in the plasma. The matrix-matched solutions are prepared with Al stock solution prepared in 15.2 and various acids to match the sample matrix. These are spiked with aliquots of single element certified reference material (CRM) solutions or stock solutions prepared as directed in Practice E1452 and contain the analytes to be quantified and the internal standard if used.

15.1.1 *Calibration Solutions*, traceable to an SI unit through a national metrology organization, shall be prepared from certified stock solutions, typically 1000 mg/L or 10 000 mg/L, or stock solutions prepared as directed in Practice E1452.

15.1.2 The composition for each element in the calibration solution should bracket the expected level of the element in solution. Aluminum matrix solution (50 g/L), prepared in 15.2, and acid should be added to the calibration solutions to match the amount of aluminum and acid that is in the final sample solution.

NOTE 2—Paragraphs 15.1.1 and following describe the preparation of alloy matrix-matched calibration solutions for analysis of sample solutions that contain 0.5 g alloy/500 mL final dilution. It is acceptable to vary both the sample mass and final volume as long as the mass and volume chosen demonstrate the required sensitivity and precision as described in 14.2 and 14.3. It is recommended that sample mass should be at least 0.1 g to ensure representative sampling.

15.1.3 Determine the number and concentrations of the calibration solutions needed to cover the concentration range for each element. The calibration solutions should have the highest concentration slightly above the highest expected sample solution concentration, the lowest concentration near the lowest expected sample solution concentration, a concentration near the mid-range between the high and low calibration solutions, and a blank. A minimum of three calibration solutions and a blank should be used for calibration of each element.

15.2 Aluminum Stock Solution for Matrix Matching:

15.2.1 Prepare a 50 g/L Al matrix solution as follows: Weigh 50 g of Al drillings, chips, millings, turnings, or powder to the nearest milligram, transfer to a 1 L beaker and add about 150 mL of water and about 300 mL of HCl in small increments.

Warning—If powdered aluminum is used, add the acid cautiously since powdered aluminum tends to be very reactive.

15.2.2 Place the beaker on a hot plate and heat the solution to approximately 90 °C to start the reaction. Remove the